

**Notice of References Cited**

Application/Control No.

10/812,040

Applicant(s)/Patent Under

Reexamination

HEER ET AL.

Examiner

Felix J. Nepveux

Art Unit

1617

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	<del>US-WO98/33380</del>	<del>08-1998</del>	<del>Wolfgang et al.</del>	<del>A01N 43/40</del>
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002-316903-A	10-2002	JP	Hisanari	A01N 43/64
	O	W098/33380	08-1998		Wolfgang et al.	A01N 43/40
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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